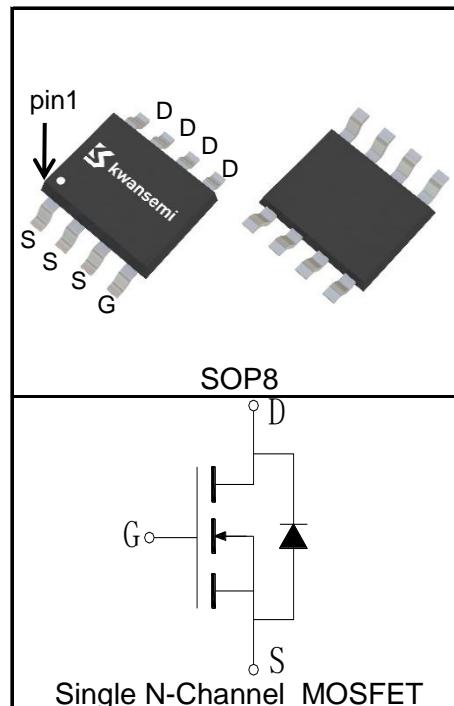


## Features

- 100V/9A,  $R_{DS(on)} = 14\text{m}\Omega$ (Typ.)@ $V_{GS}=10\text{V}$
- $R_{DS(on)} = 18\text{m}\Omega$ (Typ.)@ $V_{GS}=4.5\text{V}$
- Excellent  $Q_G \times R_{DS(on)}$  product(FOM)
- SGT Technology
- Fast Switching Speed
- Low Capacitance to Minimize Driver Losses

## Pin Description



## Applications

- Switch Mode Power Supply



Halogen-Free

## Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit
<b>Common Ratings</b> ( $T_A=25^\circ\text{C}$ Unless Otherwise Noted)			
$V_{DSS}$	Drain-Source Voltage	100	V
$V_{GSS}$	Gate-Source Voltage	$\pm 20$	
$T_{Jmax}$	Maximum Junction Temperature	150	°C
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to 150	°C
$I_S$	Diode Continuous Forward Current	$T_A=25^\circ\text{C}$	2.9
			A

### Mounted on Large Heat Sink

$I_{DP}^{(1)}$	Pulse Drain Current	$T_A=25^\circ\text{C}$	36	A
$I_D^{(2)}$	Continuous Drain Current( $V_{GS}=10\text{V}$ )	$T_A=25^\circ\text{C}$	9	A
		$T_A=70^\circ\text{C}$	7.2	
$P_D$	Maximum Power Dissipation	$T_A=25^\circ\text{C}$	2.5	W
		$T_A=70^\circ\text{C}$	1.6	
$R_{\theta JL}$	Thermal Resistance-Junction to Lead		35	°C/W
$R_{\theta JA}^{(3)}$	Thermal Resistance-Junction to Ambient		50	°C/W

### Drain-Source Avalanche Ratings

$E_{AS}^{(4)}$	Avalanche Energy, Single Pulsed	81	mJ
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**Electrical Characteristics (T<sub>A</sub>=25°C Unless Otherwise Noted)**

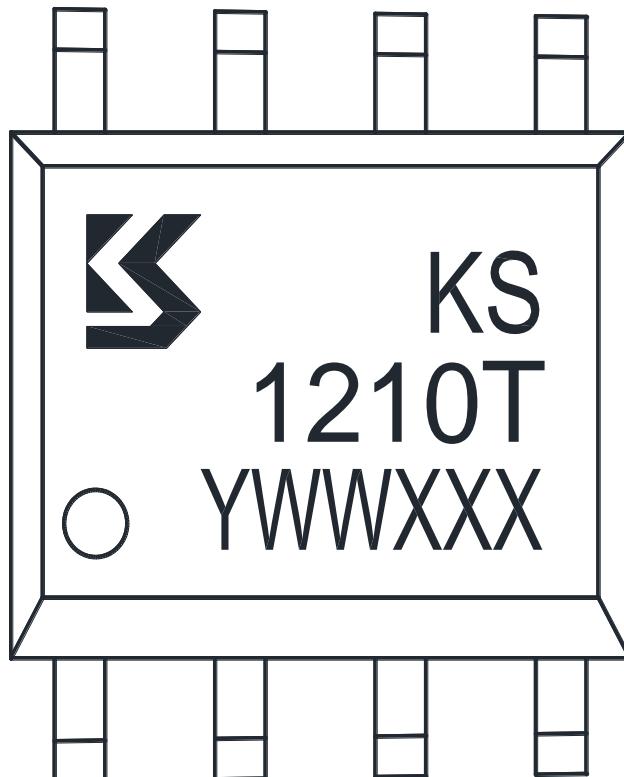
Symbol	Parameter	Test Condition	Rating			Unit
			Min.	Typ.	Max.	
<b>Static Characteristics</b>						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>DS</sub> =250μA	100			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V			1	μA
		T <sub>J</sub> =125°C			30	
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =250μA	1.2	2	2.4	V
I <sub>GSS</sub>	Gate Leakage Current	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V			±100	nA
R <sub>DS(ON)</sub> <sup>⑤</sup>	Drain-Source On-state Resistance	V <sub>GS</sub> =10V, I <sub>DS</sub> =10A		14	17	mΩ
		V <sub>GS</sub> =4.5V, I <sub>DS</sub> =8A		18	24	mΩ
<b>Diode Characteristics</b>						
V <sub>SD</sub> <sup>⑤</sup>	Diode Forward Voltage	I <sub>SD</sub> =10A, V <sub>GS</sub> =0V		0.84	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>SD</sub> =10A, dI <sub>SD</sub> /dt=100A/μs		32		ns
Q <sub>rr</sub>	Reverse Recovery Charge			43		nC
<b>Dynamic Characteristics</b> <sup>⑥</sup>						
R <sub>G</sub>	Gate Resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, F=1MHz		1.4		Ω
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =50V, Frequency=200KHz		990		pF
C <sub>oss</sub>	Output Capacitance			205		
C <sub>rss</sub>	Reverse Transfer Capacitance			4		
t <sub>d(ON)</sub>	Turn-on Delay Time	V <sub>DD</sub> =50V, I <sub>DS</sub> =10A, V <sub>GEN</sub> =10V, R <sub>G</sub> =6Ω		6		ns
t <sub>r</sub>	Turn-on Rise Time			12		
t <sub>d(OFF)</sub>	Turn-off Delay Time			20		
t <sub>f</sub>	Turn-off Fall Time			5		
<b>Gate Charge Characteristics</b> <sup>⑥</sup>						
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =50V, V <sub>GS</sub> =10V, I <sub>DS</sub> =10A		18		nC
Q <sub>gs</sub>	Gate-Source Charge			2.5		
Q <sub>gd</sub>	Gate-Drain Charge			4.6		

Notes:

- ①Pulse width limited by safe operating area.
- ②Calculated continuous current based on maximum allowable junction temperature.
- ③When mounted on 1 inch square copper board, t≤10sec. The value in any given application depends on the user's specific board design.
- ④Limited by T<sub>Jmax</sub>, Starting T<sub>J</sub> = 25°C, I<sub>ASmax</sub> = 18A, L=0.5mH, V<sub>DD</sub> = 48V, R<sub>G</sub> = 25Ω, V<sub>GS</sub>=10V. Part not recommended for use above this value.
- ⑤Pulse test; Pulse width≤300μs, duty cycle≤2%.
- ⑥Guaranteed by design, not subject to production testing.

**Ordering and Marking Information**

Device	Package	Packaging	Quantity	Reel Size	Tape width
KS1210HAT	SOP8	Tape&Reel	3000	13"	12mm

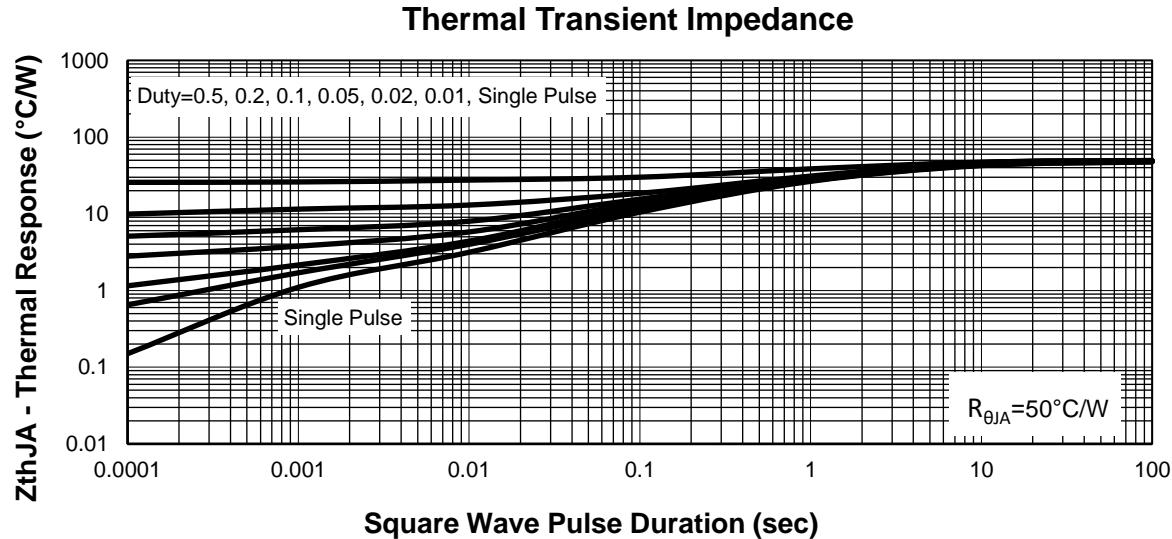
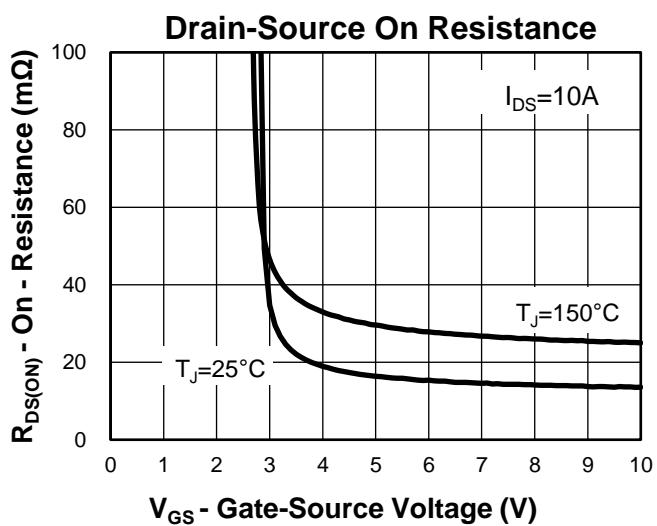
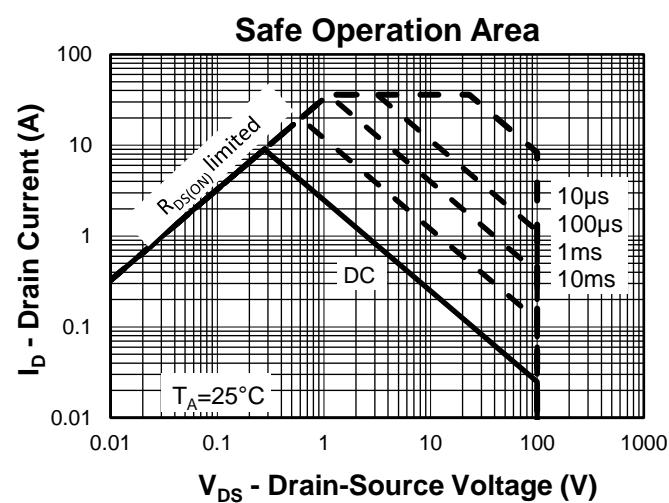
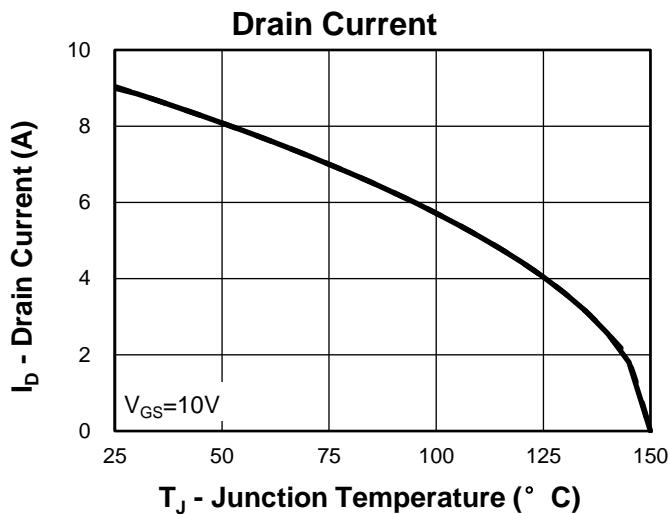
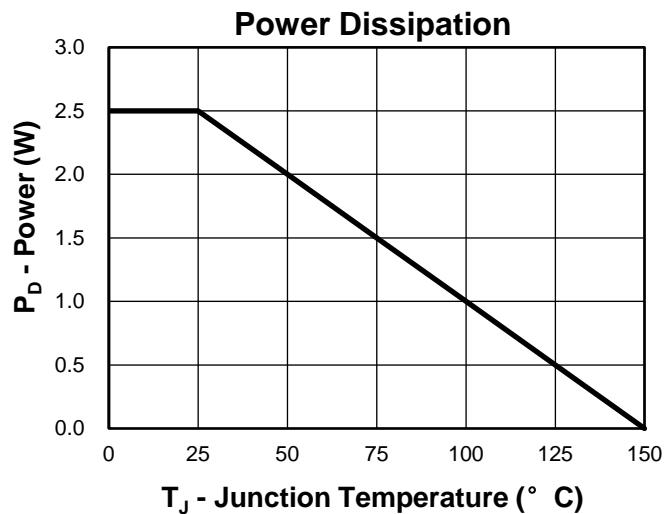


1st Line: Kwansemi LOGO, Kwansemi Code(KS)

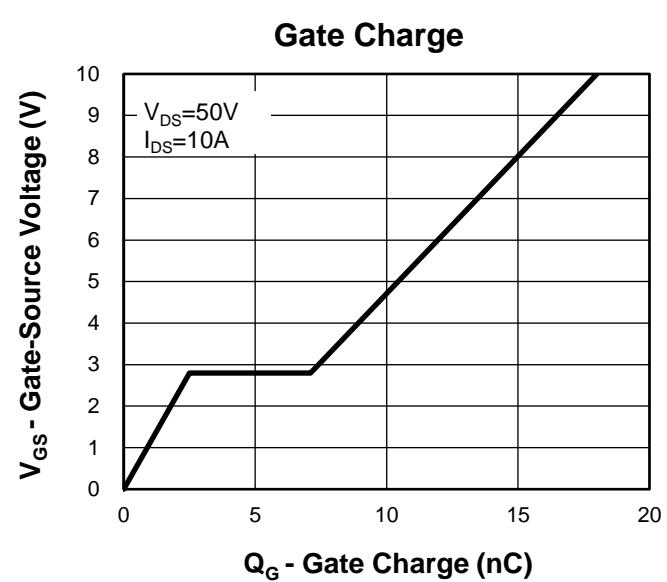
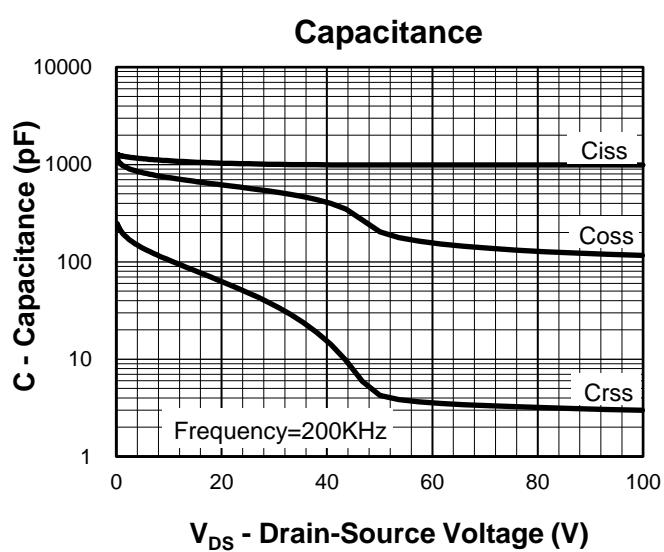
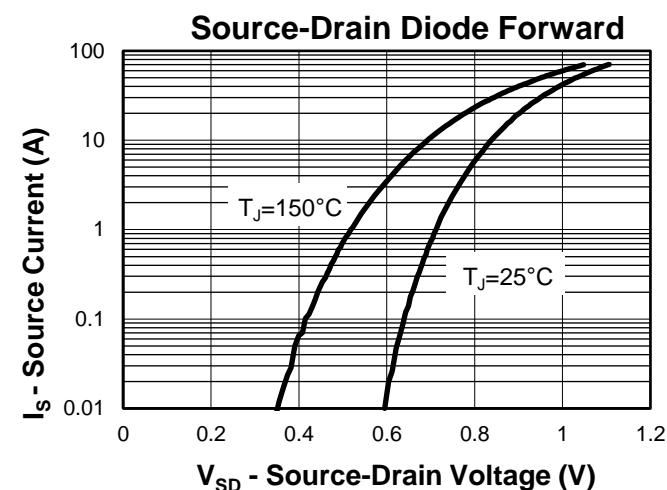
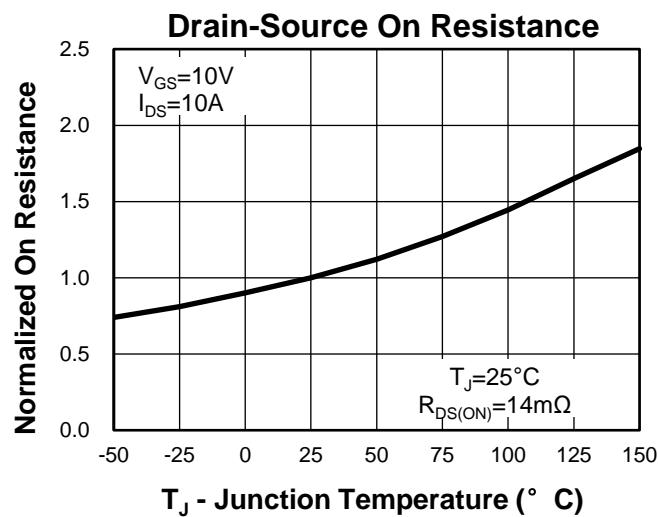
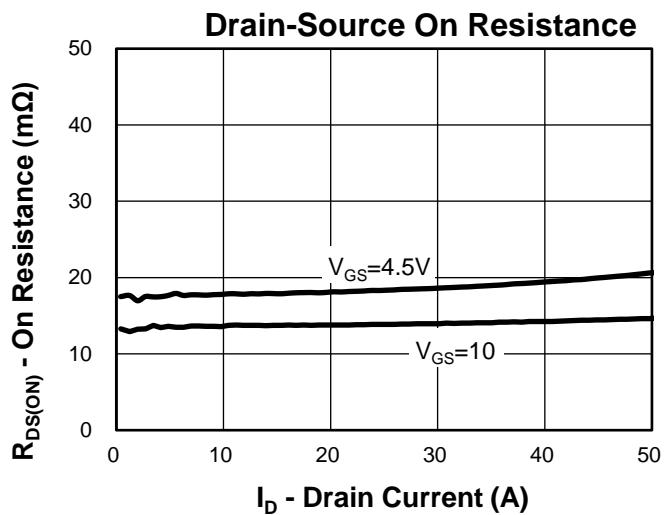
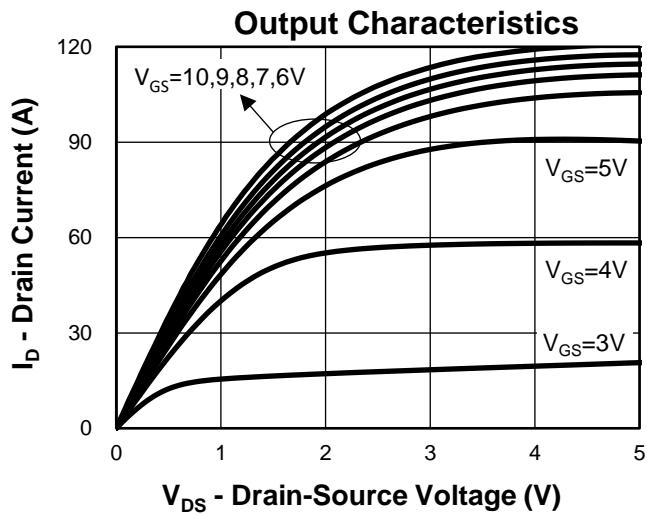
2nd Line: Part Number(1210T)

3rd Line: Lot Number(YWWXXX)

## Typical Characteristics

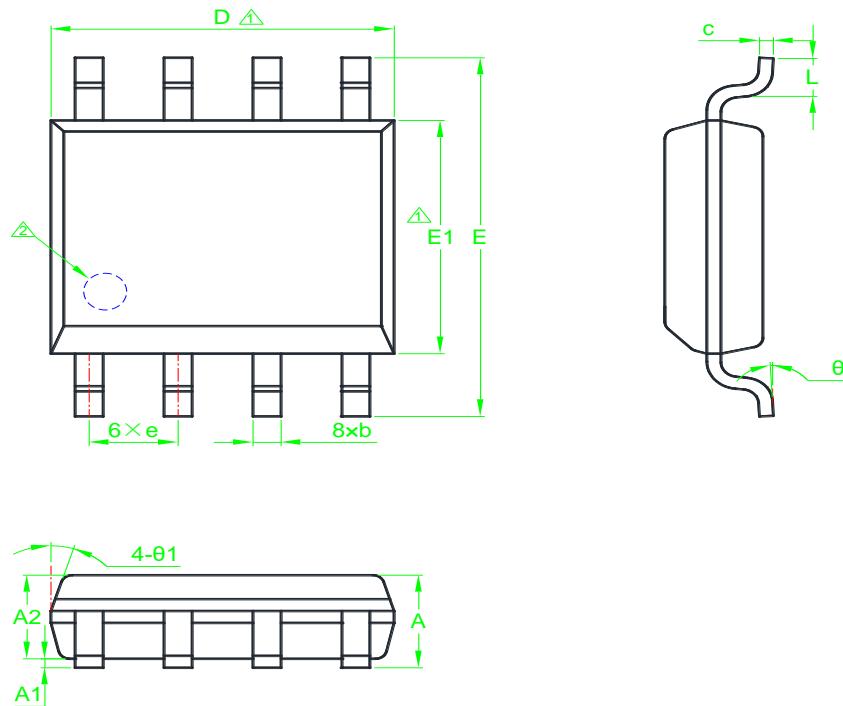


## Typical Characteristics



## Package Information

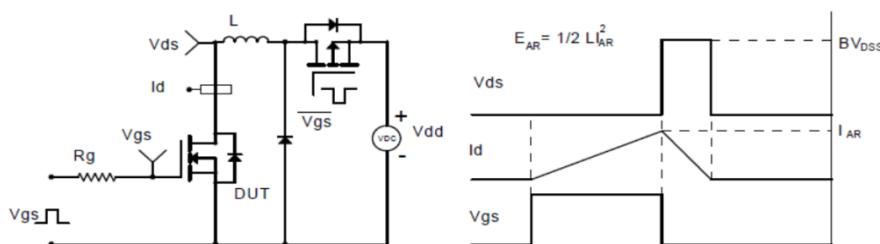
### SOP8



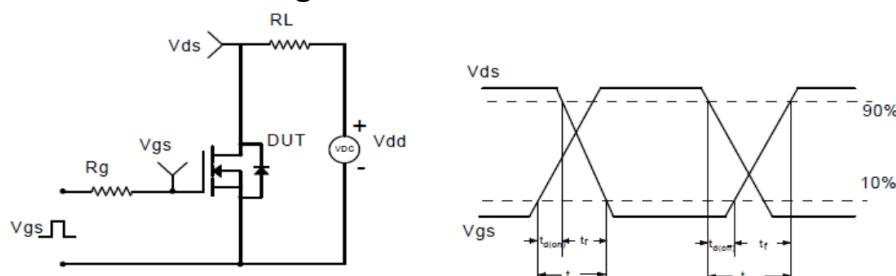
SYMBOL	MM			INCH		
	MIN	NOM	MAX	MIN	NOM	MAX
A	1.35	*	1.75	0.053	*	0.069
A1	0.10	*	0.25	0.004	*	0.010
A2	1.25	1.45	1.65	0.049	0.057	0.065
b	0.33	*	0.51	0.013	*	0.020
c	0.15	*	0.25	0.006	*	0.010
D	4.70	4.90	5.10	0.185	0.193	0.201
E	5.80	6.00	6.30	0.228	0.236	0.248
E1	3.80	3.90	4.00	0.150	0.154	0.157
e	1.27BSC			0.050BSC		
L	0.40	*	1.27	0.016	*	0.050
θ	0°	*	8°	0°	*	8°
θ 1	5°	*	15°	5°	*	15°

- 1 Dimensions D and E1 do not include mold flash protrusions or gate burrs.  
 2 The existence and size of demolding hole are variable depending on mold.

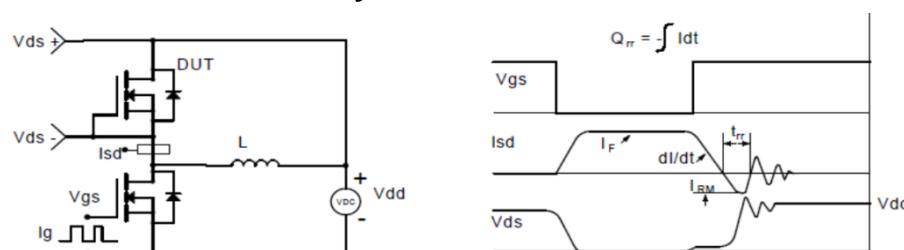
### Avalanche Test Circuit and Waveforms



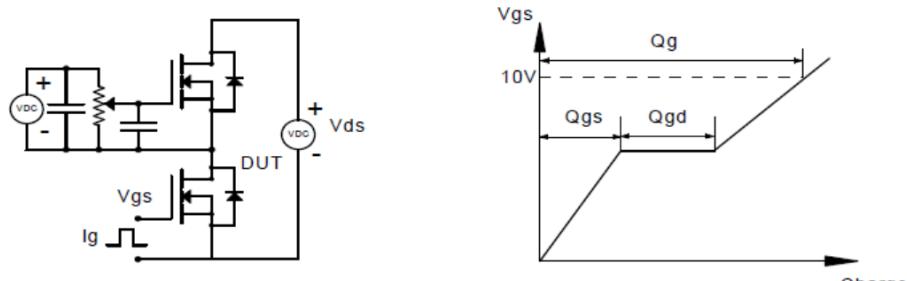
### Switching Time Test Circuit and Waveforms



### Diode Recovery Test Circuit and Waveforms



### Gate Charge Test Circuit and Waveform



### Customer Service

Kwansemi Semiconductor Co.,Ltd

Email:[Sales@kwansemi.com](mailto:Sales@kwansemi.com)

Web:[www.kwansemi.com](http://www.kwansemi.com)

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